Notice of References Cited Application/Control No. 10/742,695 Examiner SAIF A. ALHIJA Applicant(s)/Patent Under Reexamination QADEER ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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NON-PATENT DOCUMENTS

	NON TALL DOGGINENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
*	U	Tyrrell et al. "CSP Methods for Identifying Atomic Actions in the Design of Fault Tolerant Concurrent Systems" IEEE 1995					
*	V	Reps et al. "Precise Interprocedural Dataflow Analysis via Graph Reachability", 1995 ACM.					
	W						
	x						

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